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SERIAL NUMBER 09/891,693	FILING DATE 06/26/2001 RULE	CLASS 356	GROUP ART UNIT 2877	ATTORNEY DOCKET NO. M-10693 US
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APPLICANTS

Steve Biellak, Sunnyvale, CA;

Stanley E. Stokowski, Danville, CA;
Mehdi Vaez-Iravani, Los Gatos, CA;** CONTINUING DATA *yes*This application is a CIP of 09/746,141 12/21/2000 PAT 6,639,662
which is a CON of 08/933,771 09/19/1997 PAT 6,201,601** FOREIGN APPLICATIONS *None*

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 08/17/2001

Foreign Priority claimed	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no	STATE OR COUNTRY	SHEETS	TOTAL	INDEPENDENT
35 USC 119 (a-d) conditions met	<input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance		DRAWING	CLAIMS	CLAIMS
Verified and Acknowledged <i>[Signature]</i>	Examiner's Signature Initials	CA	3	45	4

ADDRESS

36257
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TITLE

Systems and methods for a wafer inspection system using multiple angles and multiple wavelength illumination

FILING FEE	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time)
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